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Pulsed Power Conference, 1997. Digest of Technical Papers. 1997 11th IEEE International, Volume: 1, 29 June-2 July 1997

Page(s): 250 -255 vol.1

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Pulsed Power Plasma Science, 2001. IEEE Conference Record - Abstracts, 1, 2001

Page(s): 330

[\[Abstract\]](#) [\[PDF Full-Text \(52 KB\)\]](#) **IEEE CNF****3 FCOB reliability evaluation simulating multiple rework/reflow process***Chen, W.; Gentile, J.; Higgins, L.;*

Electronic Components and Technology Conference, 1996. Proceedings., 46th May 1996

Page(s): 1184 -1195

[\[Abstract\]](#) [\[PDF Full-Text \(1704 KB\)\]](#) **IEEE CNF****4 Design of a Shipboard Handling System for a Ten Air Gun Array***Collier, M.;*

OCEANS, Volume: 13, Sep 1981

Page(s): 1049 -1052

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5 The UCLA IR-FEL

*Aghamir, F.; Barletta, W.; Cline, D.; Dodd, J.; Hartmann, S.; Joshi, C.; Kolo
Luhmann, N.; McDermott, D.; Pellegrini, C.; Terrien, C.;*

Plasma Science, 1990. IEEE Conference Record - Abstracts., 1990 IEEE Inter
Conference on , 21-23 May 1990

Page(s): 195

[\[Abstract\]](#) [\[PDF Full-Text \(104 KB\)\]](#) **IEEE CNF**

6 Overcurrent protection control technique of ZCS series resonant re

Young Seok Jung; Jong Sun Ko; Gun Woo Moon; Myung Joong Youn;

Power Electronics and Drive Systems, 1995., Proceedings of 1995 Internatio
Conference on , 21-24 Feb. 1995

Page(s): 672 -676 vol.2

[\[Abstract\]](#) [\[PDF Full-Text \(228 KB\)\]](#) **IEEE CNF**

**7 Tactical jet aircraft detection, targeting, and elimination using pne
ballistics projectiles**

Wrigley, C.J.;

WESCON/96 , 22-24 Oct. 1996

Page(s): 634 -639

[\[Abstract\]](#) [\[PDF Full-Text \(476 KB\)\]](#) **IEEE CNF**

8 Low-energy high-current electron beams: production and applicati

Proskurovsky, D.I.; Ozur, G.E.; Rotshtein, V.P.;

Plasma Science, 1998. 25th Anniversary. IEEE Conference Record - Abstract:
IEEE International on , 1-4 June 1998

Page(s): 252 -253

[\[Abstract\]](#) [\[PDF Full-Text \(160 KB\)\]](#) **IEEE CNF**

**9 Compact installation for radiation processing of materials by accele
electrons**

*Krylov, S.; Latypov, T.; Mamaev, G.; Mamaev, S.; Microchnik, E.; Priozhenk
Poutchkov, S.; Seleznev, I.; Tenjakov, I.; Korolev, A.; Simonov, K.;*

Particle Accelerator Conference, 1999. Proceedings of the 1999 , Volume: 4 ,
March-2 April 1999

Page(s): 2567 -2569 vol.4

[\[Abstract\]](#) [\[PDF Full-Text \(236 KB\)\]](#) **IEEE CNF**

10 A study on lung nodule detection using neural networks

Ju-Won Lee; Han-Wook Lee; Jong-Hoe Lee; Ick-Tae Kang; Gun-Ki Lee;

TENCON 99. Proceedings of the IEEE Region 10 Conference , Volume: 2 , 15-1999

Page(s): 1150 -1153 vol.2

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11 A three level ZVZCS phase-shifted DC/DC converter using a tappe and a snubber capacitor

Eun-Soo Kim; Young-Bok Byun; Yoon-Ho Kim; Young-Gun Hong;

Applied Power Electronics Conference and Exposition, 2001. APEC 2001. Sixt Annual IEEE , Volume: 2 , 4-8 March 2001

Page(s): 980 -985 vol.2

[\[Abstract\]](#) [\[PDF Full-Text \(376 KB\)\]](#) **IEEE CNF**

12 Compact flexible pellet injection system for plasma fueling experi

Combs, S.K.; Foust, C.R.; Baylor, L.R.; Cole, M.J.; Fehling, D.T.; Fisher, P.W M.J.; Rasmussen, R.A.; Sparks, D.O.; Wilgen, J.B.;

Fusion Engineering, 2002. 19th Symposium on , 21-25 Jan. 2002

Page(s): 76 -79

[\[Abstract\]](#) [\[PDF Full-Text \(383 KB\)\]](#) **IEEE CNF**

13 Micrometeoroid impact simulations using a railgun electromagneti accelerator

Upshaw, J.L.; Kajs, J.P.;

Magnetics, IEEE Transactions on , Volume: 27 Issue: 1 , Jan. 1991

Page(s): 607 -610

[\[Abstract\]](#) [\[PDF Full-Text \(500 KB\)\]](#) **IEEE JNL**

14 FCOB reliability evaluation simulating multiple rework/reflow pro Wayne Chen;

Components, Packaging, and Manufacturing Technology, Part C, IEEE Trans [see also Components, Hybrids, and Manufacturing Technology, IEEE Transa Volume: 19 Issue: 4 , Oct. 1996

Page(s): 270 -276

[\[Abstract\]](#) [\[PDF Full-Text \(188 KB\)\]](#) **IEEE JNL**

15 Coaxial cavity gyrotron- recent experimental results

Piosczyk, B.; Arnold, A.; Dammertz, G.; Dumbrajs, O.; Kuntze, M.; Thumm,
Plasma Science, IEEE Transactions on , Volume: 30 Issue: 3 , June 2002
Page(s): 819 -827

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